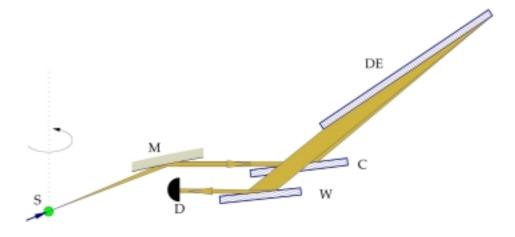
Proposal of a novel spectrometer for inelastic X-ray scattering with meV resolution

SHVYD'KO Yuri

Universität Hamburg, Institut für Experimentalphysik



A concept of a new spectrometer for inelastic x-rays scattering (IXS) with meV and submeV resolution will be presented. The main distinguishing features of the spectrometer are:

- 1. Spectral properties improve with decreasing photon energy. Most optimal performance in the low-energy spectral range $E \approx 5 10$ keV.
- 2. Applicable even at low-energy synchrotron radiation facilities (including X-FELs).
- 3. Higher countrates, since undulators produce much more photons in the low-energy range (also at high-energy synchrotron radiation facilities).
- 4. Variable energy bandpass from $\Delta E \approx 5$ down to ≈ 0.2 meV at a fixed photon energy *E*.
- 5. Peak throughput practically independent of the energy bandpass ΔE .
- 6. Using low-energy photons means better momentum transfer resolution for the same angular acceptance.
- 7. Proximity to *K*-absorption edges of the important transition metals.

Principles and example designs of the spectrometer will be discussed.